Search Notes



Applicant(s)/Patent Under
Reexamination

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NAKAMURA ET AL.

Examiner

Art Unit

MY-CHAU T TRAN

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SEARCHED

Class Subclass Date Examiner				
	Subclass		Examiner	
345	55, 84, 87, 104, 156, 173, 174, 175, 179	08/04/2008	MCT	
178	18.01, 18.03, 18.05, 18.06, 18.07, 18.11	08/04/2008	MCT	
UPDATED	UPDATED - see printout	12/05/2008	MCT	

SEARCH NOTES

Search Notes	Date	Examiner
PALM Inventors; WEST - see printout	08/04/2008	MCT
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INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
345	87 104 173 175 179 see printout	12/05/2008	MCT

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